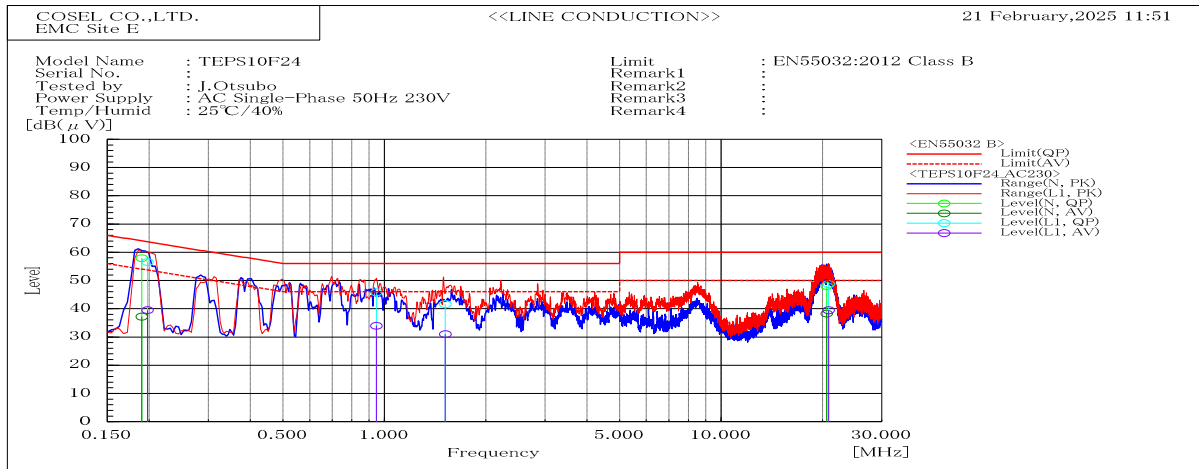
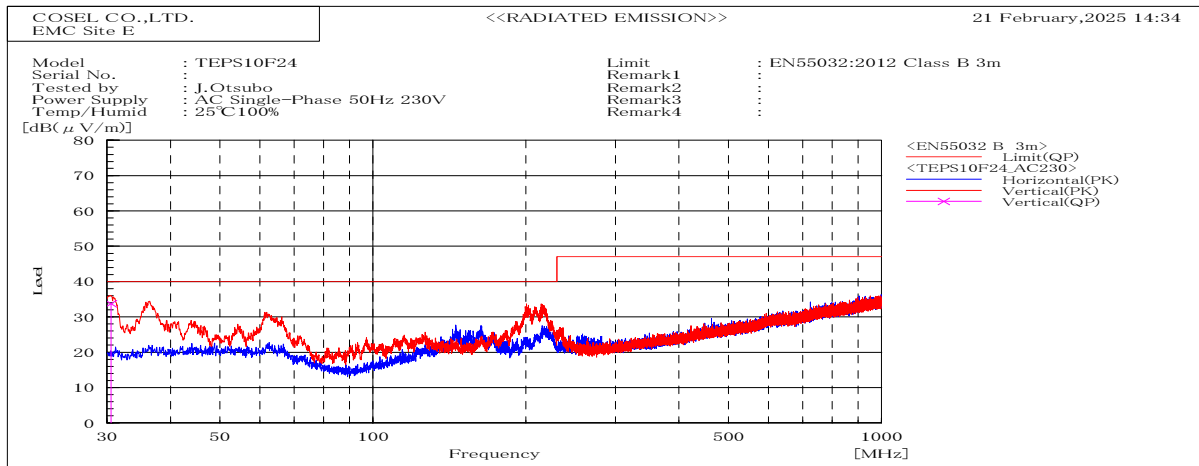


DATA SHEET		Date	24-Mar-25
Model	TEPS10F24	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Sakuma



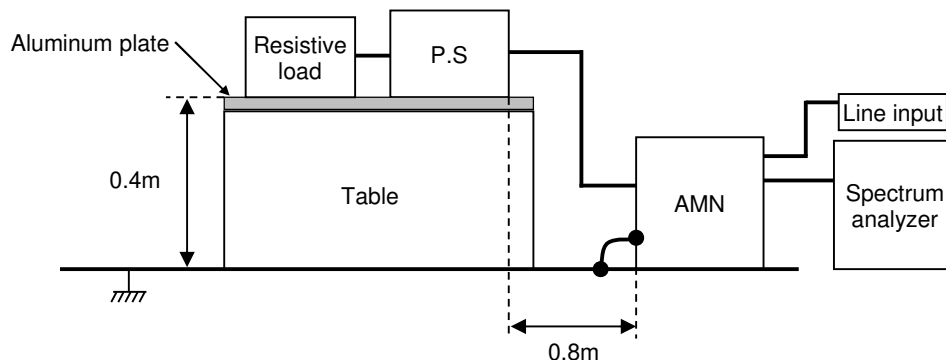
Frequency	Line	Level		Limit		Margin		Pass/Fail	Remark
MHz		dB(μV)		dB(μV)		dB			
		QP	AV	QP	AV	QP	AV		
0.198	L1	56.5	39.5	63.7	53.7	7.2	14.2	Pass	
1.516	L1	41.6	31	56	46	14.4	15	Pass	
0.947	L1	45.8	34	56	46	10.2	12	Pass	
20.867	L1	48.8	39.5	60	50	11.2	10.5	Pass	
0.19	N	57.9	37.2	64	54	6.1	16.8	Pass	
20.589	N	48.1	38.3	60	50	11.9	11.7	Pass	



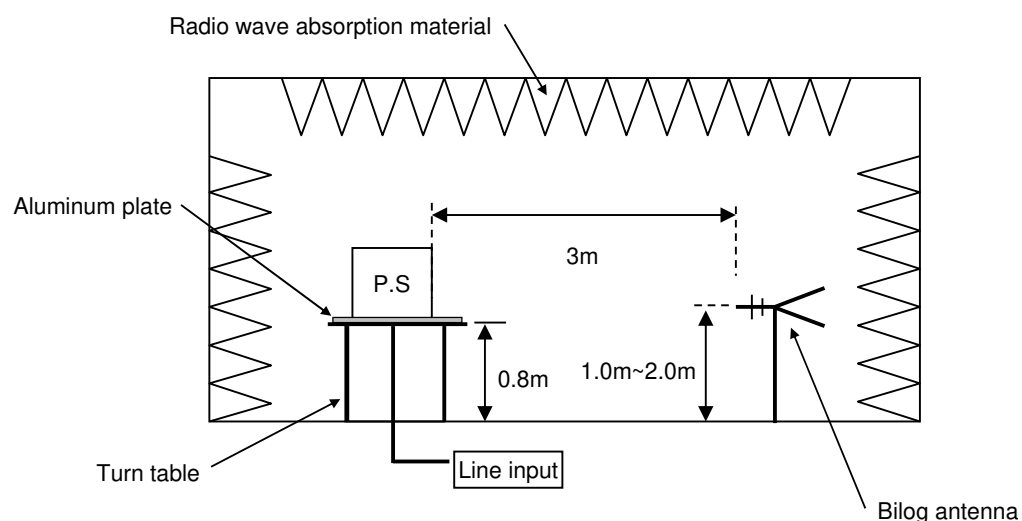
Frequency	Polarization	Stability	Level	Limit	Margin	Pass/Fail	Height	Angle	Remark
MHz			dB(μV/m)	dB(μV/m)	dB				
			QP	QP	QP		cm	deg	
30.571	V	Stable	33.7	40	6.3	Pass	100	128.7	

DATA SHEET		Date	24-Mar-25
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Sakuma

1. Line conduction



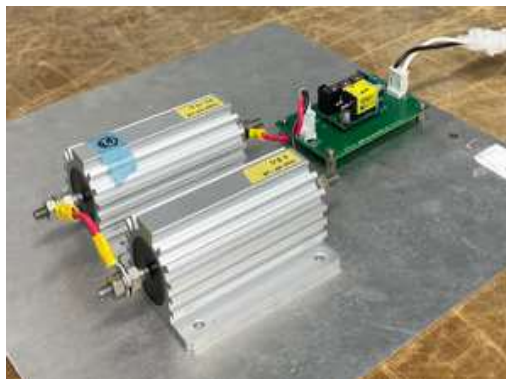
2. Radiated emission



Conditions

Test : EMI
Model Name : TEPS10F24

1.LINE CONDUCTION



2.RADIATED EMISSION

